



2622

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of
Yoshinori MURAMATSU

Application. No.: 09/730,313

Filed: December 5, 2000

For: **IMAGE SENSOR AND METHOD OF
DRIVING THE SAME**


Art Unit: 2622

Examiner: To be assigned

Docket No.: APM-01401

#8
TC
1-27-04**Certificate of Mailing**

I hereby certify that the foregoing documents are being deposited with the United States Postal Service as first class mail, in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on this date of January 6, 2004.


Name: Tracey A. Newell**INFORMATION DISCLOSURE STATEMENT****RECEIVED**

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

JAN 12 2004

Sir:

TC 2600**RECEIVED**

JAN 12 2004

Technology Center 2600

Submitted herewith on Form PTO-1449 is a listing of documents known to Applicants and/or their attorney in compliance with the requirements of 37 C.F.R. 1.56. Copies of the documents are also being submitted.

The references cited herein were cited in connection with a November 25, 2003 foreign Office Action (copy enclosed) for a counterpart application in the Japanese Patent Office. Thus, since this Information Disclosure Statement is being filed within three months of that date and prior to either a Final Office Action or Notice of Allowance being mailed for this case, no fee is due.

In compliance with the requirements of 37 C.F.R. §1.98(a)(3), as a concise statement of relevance, as it is presently understood by the individual designated in 35 U.S.C. §1.56(c) most knowledgeable about the content of the information, the undersigned attorney of record submits

a translation of portions of an official action by a foreign examiner. A copy of the official action is enclosed. The relevance to the pending U.S. patent application is that the references were cited in a foreign patent application corresponding to the above-captioned U.S. patent application. However, no independent analysis of the references, the accuracy of the statement of the foreign examiner or the claims of the foreign application under the laws of that country or the United States relative to the subject matter claimed in the present application has been made; the present understanding of the contents thereof by the undersigned being based on the translation of the foreign examiner's comments submitted herewith.

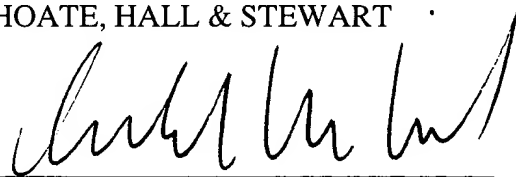
The Examiner is respectfully requested to initial the space adjacent to each document on the PTO-1449 form and return a copy of the PTO-1449 form to confirm that these documents have been considered by the Examiner and made of record in this application.

Although we believe that we have appropriately provided for any fees due in connection with this submission, the Commissioner is authorized to credit any overpayment or charge any deficiencies to/from our **Deposit Account No. 031721**. Two originally-executed copies of this form are being submitted.

Should there be any questions after reviewing this paper, the Examiner is invited to contact the undersigned at (617) 248-4038.

Respectfully submitted,

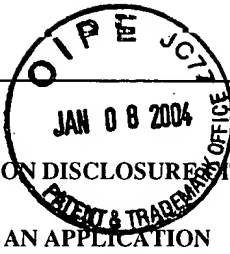
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January 6, 2004
Date

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<div style="display: flex; justify-content: space-between; align-items: center;"> <div> Form PTO-1449 INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i> </div> <div style="text-align: center;">  </div> <div> Sheet 1 of 1 APM-01401 </div> <div> Application Number 09/730,313 </div> </div>						
Applicant Yoshinori MURAMATSU						
Filing Date December 5, 2000	Group Art Unit 2622					
U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA						
AB						
AC						
AD						
AE						
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
AF	H9-233393	09/05/1997	JP			
AG	H9-51485	02/18/1997	JP			
AH						
AI						
AJ						
AK						
AL						
AM						
AN						
AO						
AP						
AQ						
AR						
AS						
AT						
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>						
AU						
AV						
AW						
EXAMINER			DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.						

Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE